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Defect-Mediated Properties of Magnetic Tunnel Junctions

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Defects play an important role in the properties of metal oxides which are currently used as barrier layers in magnetic tunnel junctions (MTJs). We study the effect of O vacancies on the interlayer exchange coupling (IEC) and tunneling magnetoresistance (TMR) in Fe–MgO–Fe tunnel junctions. Measurements of IEC in fully epitaxial Fe–MgO–Fe(001) tunnel junctions show IEC is antiferromagnetic (AFM) for small MgO thickness but changes sign and then vanishes for large barrier thickness. First-principles calculations based on density functional theory demonstrate that the presence of neutral O vacancies (*F*-centers) in the MgO barrier can explain this behavior. Resonant tunneling through the *F*-centers makes IEC AFM for thin barriers but with increasing MgO thickness the resonance contribution to IEC is reduced resulting in the ferromagnetic (FM) coupling typical for perfect MgO barriers. First-principles calculations also show that O vacancies can affect TMR. *F*-centers produce occupied localized *s*-states and unoccupied resonant *p*-states in the gap of MgO. We demonstrate that *F*-centers affect the conductance by either resonant transmission or nonresonant scattering of tunneling electrons both causing a substantial reduction of TMR compared to the ideal case.

Index Terms—Heterostructures, magnetic coupling, magnetic memories, magnetic recording.

I. INTRODUCTION

SPIN-BASED electronics has a potential for exciting new applications [1]. Magnetic tunnel junctions (MTJs) look promising for magnetic recording and computer memory applications. An MTJ consists of two ferromagnetic (FM) electrodes magnetically decoupled by a thin insulating barrier [2]. The change of the electrical resistance of the MTJ with a change in the relative magnetization orientation of the electrodes is known as tunneling magnetoresistance (TMR). The interlayer exchange coupling (IEC) is a measure of the magnetic coupling between the two FM layers [3].

Since the first observation of large reproducible TMR at room temperature in amorphous Al₂O₃-based MTJs [4], there has been a surge in research in this field. In particular, giant TMR values of more than 1000% were predicted, theoretically, in MTJs based on crystalline MgO barriers epitaxially grown on Fe(001) electrodes [5], [6]. This prediction was followed by experimental realizations of MTJs utilizing both epitaxial and textured Fe and CoFe electrodes [7], [8] in which more modest TMR values of up to 300% were obtained at low temperatures. Several sources for this discrepancy mainly related to interface imperfections have been investigated such as oxidation [9] and roughness [10]. Although the interface plays an important role, defects in the insulator can also influence the properties of MTJs [11], [38]. In particular, it was found that impurity-assisted resonant tunneling can reverse TMR [12], [13].

IEC was discovered in metallic multilayers [14] and was found to oscillate as a function of spacer thickness [15]. Experimental observations of IEC across an insulator are still rare [17], [16]. The theoretical approaches to IEC are based either on the spin torque exerted by one ferromagnet on the other [18], [19] or the induced DOS in the spacer by the ferromagnets [20], [21]. For a metallic spacer, the theory predicts an oscillatory

coupling and relates the period of the oscillations to the spanning vectors of the Fermi surface of the spacer material. For an insulating spacer, a nonoscillatory dependence is expected with the strength of IEC exponentially decreasing as a function of barrier thickness. The experimental results significantly differ from the theoretical predictions for ideal MTJs both in the magnitude and the sign of IEC. The presence of impurities or defects in the barrier may significantly influence IEC [22], [23].

Defects in metal oxides have been exhaustively studied in quantum chemistry because they determine the chemical properties of the oxides [24]. Although defects must play a crucial role in real MTJs with oxide barriers, first-principles models so far have mostly been limited to ideal MTJs. In this paper, we use large scale first-principles calculations based on density functional theory to elucidate the effect of neutral O vacancies (*F*-centers) on IEC and TMR in crystalline Fe–MgO–Fe(001) MTJs. We find that resonant tunneling through the *F*-centers makes IEC AFM for thin barriers. This explains the observed IEC as a function of MgO barrier thickness in fully epitaxial Fe–MgO–Fe(001) MTJs. We also show that O vacancies affect the conductance by either resonant transmission or nonresonant scattering of electrons both causing a substantial reduction of TMR.

II. VACANCIES IN MgO

It has been well established that the properties of metal oxides are strongly influenced by the presence of defects [24]. O vacancies are of special interest because they are common to all oxides. Bulk *F*-centers were studied extensively using optical spectroscopy [25]. Recently, *F*-centers in thin MgO films were investigated using electron paramagnetic resonance [26] and scanning tunneling spectroscopy [27]. There is continuing theoretical interest in the physical properties of *F*-centers in MgO in the bulk [28], [29] and on the surface [30].

We use a pseudopotential plane-wave method (VASP) [31] within the local density approximation (LDA) to study the electronic structure of *F*-centers in the bulk MgO and in the barrier layer of Fe–MgO–Fe MTJs. In bulk MgO, vacancies are introduced by removing a neutral O atom in a 32, 64, and 216

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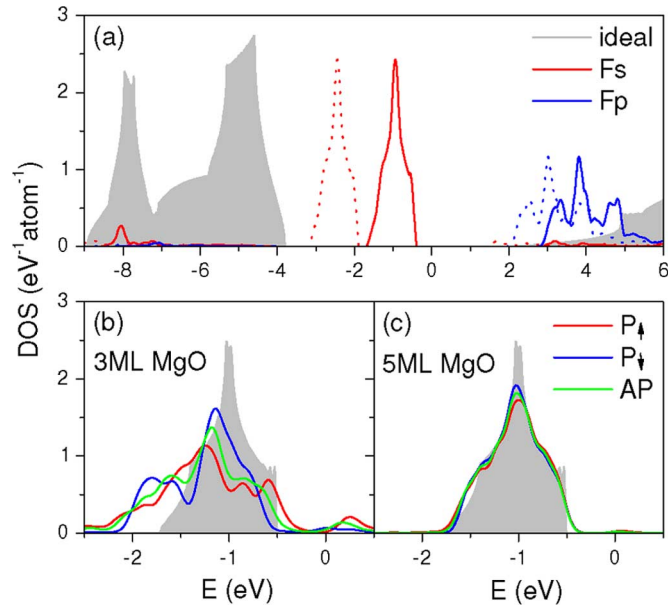


Fig. 1. DOS of (a) bulk MgO (shaded area) and F -center s and p -states for a $(1)/(32)$ cell (solid line). The dashed line indicates the approximate position of the levels corrected for self-interaction; (b) and (c) F -center s -state in bulk MgO (shaded area) and Fe–MgO–Fe MTJ (majority (P_{\uparrow}) and minority (P_{\downarrow}) in parallel and antiparallel (AP) orientation of the magnetization in the electrodes). Both cells have $(1/4)$ vacancy concentration in plane. $E = 0$ is the position of the Fermi level in Fe–MgO–Fe MTJs.

atom supercells.¹ Atomic relaxations show that the MgO lattice is only slightly distorted in the vicinity of the vacancy. Fig. 1(a) shows the calculated density of states (DOS) of an F -center superimposed on DOS of bulk MgO. The O vacancy produces two localized states, one above and one below the Fermi level (E_F). The first state has s character and it is occupied by two electrons on the F -center site. The s character is evident from the partial DOS as well as from the spherically symmetric charge density on the vacancy site seen in Fig. 2(a). The charge density plot reveals significant hybridization only between the vacancy s -state and p -states of the nearest O ions. The second state is an unoccupied p -state which appears on the F -center site at the bottom of the MgO conduction band (Fig. 1). Since the F -center p -state lies within the continuum of the conduction-band states, a nonzero charge density is present on atoms far away from the vacancy site [Fig. 2(b)]. Our results are consistent with the earlier calculations of the electronic structure of O vacancies in MgO [28].

These results conform with the experimental data [26], [27] where two defect levels are observed in the band gap of MgO [26, Fig. 3(a)], [27, Fig. 3(c)]—one centered a few electronvolts above the valence band maximum (VBM) and another overlapping with the conduction band minimum. The first level can be identified with the F -center ground s -state while the second corresponds to the F -center excited p -state. It is unlikely that the occupied localized level represents a V -center formed by a neutral Mg vacancy, as suggested in [27], because the formation energy of a V -center is substantially larger than that of an F -center

¹Supercells are tetragonal for the 32 atom cell $2a_{\text{Fe}}(1, 1, \sqrt{2})$ and cubic for the 64 and 216 atom cells with edge size $2a_{\text{MgO}}$ and $3a_{\text{MgO}}$, respectively. $a_{\text{Fe}} = 2.87 \text{ \AA}$ is the experimentally observed lattice constant of Fe and $a_{\text{MgO}} = \sqrt{2}a_{\text{Fe}}$.

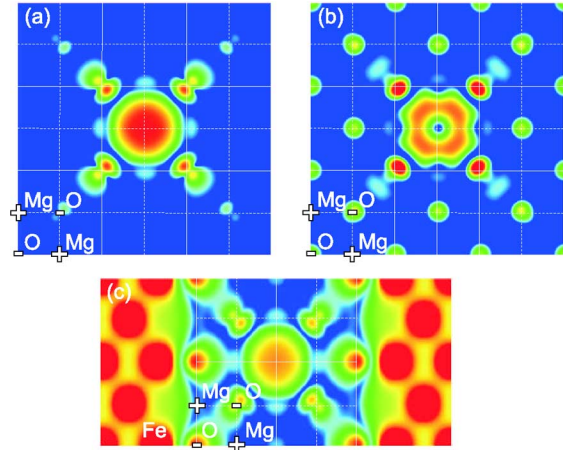


Fig. 2. Charge density calculated in the energy window containing the defect level (a) and (b) MgO s - and p -states ($(1)/(216)$ cell); (c) Fe–MgO–Fe(001) with five layers of MgO and one O vacancy in the middle MgO layer ($(1)/(8)$ cell). Vacancy is in the middle, the positions of the Mg (+) and O (–) atoms are indicated for one unit cell. Exponential scale is used with red indicating high and blue low charge density (arbitrary units).

[30]. The exact position of the occupied level varies in experiments depending on the exact environment of the vacancy and the size of the gap which is smaller close to the surface. Theoretically, the distance of the occupied level from the VBM can be understood as an upper limit. For highly localized electrons on the F -center, self-interaction corrections become important. The self-interaction energy has been estimated to be $U_{ss} = 1$ to 1.5 eV and $U_{sp} = 0.5$ to 0.8 eV [28]. Fig. 1(a) shows the approximate positions of the F -center levels after the self-interaction has been subtracted which agree well with the experimental data.

To simulate vacancies in the barrier layer of Fe–MgO–Fe MTJs, we consider a supercell with one vacancy per 4 or 8 O atoms in the plane in the middle layer of the junction. The occupied vacancy level appears centered around -1 eV . Its width depends strongly on the vacancy density and the interaction with the electrodes. Fig. 1(b) and (c) shows F -center levels in Fe–MgO–Fe MTJs with 3 and 5 atomic layers (MLs) of MgO, respectively, compared to the F -center in bulk MgO with comparable vacancy density. The broadening of the level is intrinsic (from interaction with the other vacancies) and extrinsic (from interaction with the Fe electrodes). Fig. 1(c) demonstrates that if there is more than 2 MLs between the vacancy and the electrode, the interaction with the electrodes is weak and the broadening is purely intrinsic. If the vacancy is closer, the level is broadened due to large escape rates to the electrodes and the broadening is spin-dependent Fig. 1(b). In Fig. 2(c), the charge density in an Fe–MgO–Fe MTJs with five MLs of MgO is shown. The vacancy interacts only with the O on the neighboring layers and does not affect the O atoms on the surface.

III. IEC

The IEC energy per unit area is given by $E_{\text{IEC}} = -J \cos \theta$, where θ is the angle between the magnetizations of the two FM layers. Theoretical models have been quite successful in explaining IEC observed in metallic spacers [3]. Unlike a metallic spacer layer, the tunneling barrier leads to nonoscillatory coupling which decays exponentially as a function of the barrier

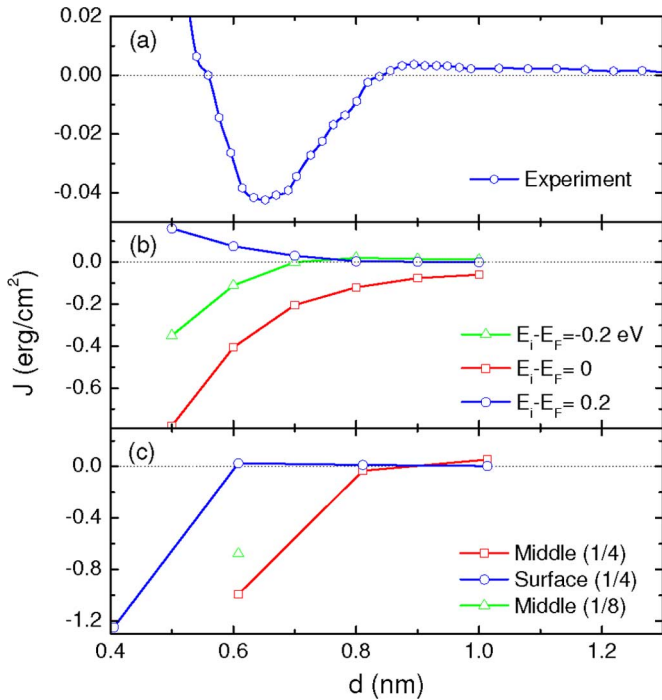


Fig. 3. IEC in Fe–MgO–Fe(001) junctions versus MgO thickness (a) measured with 15-nm free Fe layer, (b) calculated from the free electron model and averaged over the impurity position, and (c) calculated *ab initio* in VASP for a single O vacancy.

thickness [18], [19], [20], [21]. Experimental observations of IEC have been reported for only two systems—Fe–MgO–Fe [16] and Fe–Si–Fe [17]. In both cases large coupling strength is observed comparable to that of metallic spacers. Also, a model for a defect-free Fe–MgO–Fe predicts IEC to be FM at thickness less than 10 Å [22], [23]. Thus, experimental results differ from theoretical prediction both in magnitude and sign of the coupling.

A. Experiment

IEC in Fe–MgO–Fe MTJs was found to be AFM for small barrier thickness but changes sign for thicker barriers [16]. It is not clear, however, whether the switching is caused by magnetostatic interaction due to interface roughness or has intrinsic origin. In order to clarify this, we prepared fully epitaxial Fe–MgO–Fe(001) MTJs with wedge-shaped MgO by molecular beam epitaxy (MBE). The flatness of the interfaces was controlled by observing *in situ* the reflective high-energy electron diffraction (RHEED) pattern. Longitudinal magneto-optical Kerr effect (MOKE) was used to measure hysteresis loops of the free and pinned Fe layers at room temperature. Further details on synthesis and characterization of the MTJs can be found in [32].

Fig. 3(a) shows the measured dependence of IEC on MgO thickness. The coupling is large FM for MgO thickness below 0.3 nm due to pinholes. It becomes AFM for MgO thickness range of about 0.5–0.8 nm; then, it reverses to weak FM above 0.8 nm. For thicker barriers, IEC approaches gradually to zero. We find that the absolute value of IEC increases with increasing Fe free layer thickness (15, 20, and 30 nm). This indicates that the better quality and interface flatness of the MgO wedge,

achieved by increasing the thickness of the bottom Fe layer, may provide a stronger AFM coupling.

It should be pointed out that in [16] the coupling for larger barrier thickness approaches a finite value. This is attributed to the “orange peel” effect which given the quality of the sample is nearly constant at this thickness range. In our case, the coupling approaches zero in the same range of thicknesses (above 1.5 nm). Therefore, the magnetostatic interaction due to interface roughness is negligible as a consequence of the high-quality Fe–MgO interfaces and the small area of the sample at a given thickness. This excludes the “orange peel” coupling effect as the origin of the sign change of IEC.

B. Model

The change of the sign of IEC indicates that there is an AFM coupling mechanism which competes at small thickness with the FM coupling expected for ideal barriers. This can be explained by localized defect states in the barrier.

In order to demonstrate that, we calculate IEC between two semifinite FM layers separated by a plane barrier layer of thickness d from the spin current using the spin torque formalism [18]. The electronic structure of the ferromagnets is modeled by free-electron bands exchange-split by Δ_{ex} . The barrier is represented by a rectangular potential of height U_b in which a δ function located in the barrier at position r_i represents the defect. This potential creates a quantum well containing an impurity level of energy E_i [22], [23].

Fig. 3(b) shows IEC as a function of the barrier thickness. The coupling can be FM or AFM depending on the position of the defect level. If the level is below E_F , the coupling is AFM but its magnitude is larger when the level is closer to the E_F . The absolute values of IEC are significantly higher than those in the same system without impurities and proportional to the defect concentration.

The origin of the AFM exchange coupling can be understood from energy-resolved contributions to the spin current from majority and minority spin electrons shown in Fig. 4(a) and (b). The spin current has a pronounced resonant character which correlates with the local DOS shown in Fig. 4(c) and (d). The width of the impurity levels is determined by the density of metal-induced gap states at the defect position, which is larger for majority spins. The net spin current is integrated over all energies up to E_F and summed over the two spin contributions. If the defect level is filled (lies well below E_F) the net spin current appears to be majority-dominated resulting in an FM exchange coupling. However, when the defect level is partially filled (lies near E_F) the minority spin current exceeds the majority spin current due to the incomplete contribution from the resonant peaks of different width leading to an AFM coupling.

C. *Ab Initio*

It follows from our model considerations that resonant tunneling through partially filled defect levels can mediate AFM coupling. In order to confirm that this is the mechanism of the observed variation of IEC as a function of MgO thickness, we perform *ab initio* calculations of the coupling for ideal Fe–MgO–Fe MTJs and for junctions which contain O vacancies [32].

IEC is a difference in the total energy between parallel (P) and antiparallel (AP) magnetization of an MTJ, $J = (E_{\text{AP}} - E_{\text{P}})/2$.

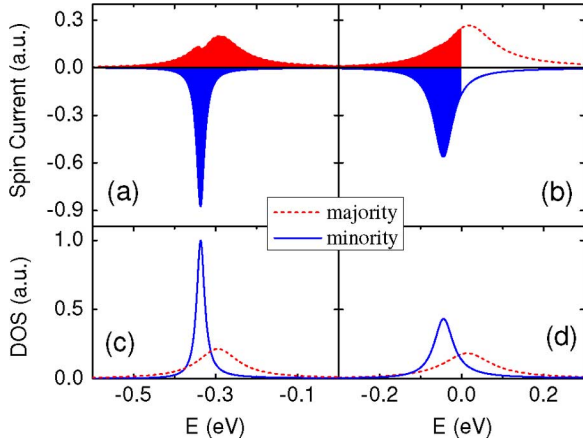


Fig. 4. Energy-resolved contributions to the spin current from majority and minority spin electrons incident from (a) and (b) the left ferromagnet and (c) and (d) DOS at the impurity position r_i for (a) and (b) $E_i = -0.3$ eV and (c) and (d) $E_i = 0$ eV. Shadow regions show filled states which contribute to the spin current at $T = 0$, $d = 8$ Å, and $r_i = 3$ Å.

We use VASP to calculate the total energy in a double supercell.² In agreement with the model predictions for an ideal MgO barrier, we find that IEC is FM [Fig. 3(c)] and decays almost perfectly exponentially with MgO thickness [32]. From the slope of the graph, we find that the decay rate of IEC is 0.4 \AA^{-1} . This value agrees very well with the slope of the conductance against MgO thickness [33] and coincides with the decay rate of the Δ_1 -state in the complex band structure of MgO [34]. This indicates that the main contribution to IEC comes from the electrons around the Fermi surface. This behavior is in agreement with theoretical predictions [18], [19], [20], [21].

Then, we calculate IEC in the presence of O vacancies assuming that they lie within one monolayer of MgO, either in the middle or on the surface of the MgO slab. It is seen from Fig. 3(c) that the coupling is AFM for small MgO thickness but changes sign at larger thickness. IEC is stronger when the vacancy lies in the middle and increases with vacancy concentration. At large thickness, the coupling becomes comparable to that of the ideal system. Thus, the presence of the vacancy provides the AFM coupling which wins at small thicknesses. Moreover, the calculated DOS on the vacancy shown in Fig. 1(b) and (c) indicates that the mechanism of the AFM coupling is indeed resonant tunneling through the F -center. For three MLs of MgO [Fig. 1(b)], the vacancy levels are broadened by the interaction with the electrodes and partially filled because their width becomes larger than the distance to the Fermi level. The broadening on the majority-spin state is larger than that of the minority-spin state due to much larger escape rates through the majority Δ_1 -state. This provides the basis for spin current imbalance and AFM coupling. For five MLs of MgO, the vacancy only weakly interacts with the leads [Fig. 1(c)] which returns the coupling to FM. The short range of the resonant tunneling through the F -center explains why the AFM coupling wins only for very small thickness.

²Supercells are tetragonal $\text{Fe}_5\text{-MgO}_n\text{-Fe}_5\text{-MgO}_n$. The $(1/8)$ cell sizes are $(2a_{\text{MgO}}, 2a_{\text{MgO}}, 5a_{\text{Fe}} + (n/2)a_{\text{MgO}} + 2h)$, where $h = 2.17$ Å is the distance between Fe and O atoms at the interface [5].

IV. TMR

TMR is defined as the normalized change of the electrical resistance of the MTJ with a change in the relative magnetization orientation of the electrodes, $\text{TMR} = (G_P - G_{AP})/G_{AP}$. Theoretically, TMR values greater than 1000% are predicted for not too small MgO thickness [5], [6], [33]. This is explained by the dominant contribution to the conductance of the Δ_1 band in Fe which is spherically symmetric in the plane of the layers and matches well with the lowest MgO conductance band (Mg s -like) resulting in low rate of decay in the insulator [5]. The other states have to tunnel through higher lying bands resulting in higher barrier heights and much higher decay rates. The asymmetry in the energy interval $(-1, 1.5)$ eV where Δ_1 appears in only in the majority spin channel, results in $G_P \gg G_{AP}$ and giant TMR.

A. Model

From inspection of the barrier DOS with defects [Fig. 1(a)], it is immediately obvious that there are two regions in which the transport properties can be expected to be essentially different. In the energy range close to the defect levels, the conductance is dominated by resonant tunneling. The resonant conductance in each spin channel is given by [13], [35]

$$G_\sigma \propto \frac{\Gamma_{L\sigma}\Gamma_{R\sigma}}{(E - E_d)^2 + (\Gamma_{L\sigma} + \Gamma_{R\sigma})^2/4} \quad (1)$$

where $\Gamma_{L\sigma}$ and $\Gamma_{R\sigma}$ are the electron escape rates to the left and right electrodes and E_d is the position of the defect level. The escape rates is $\Gamma_\sigma = \rho_\sigma e^{-2\kappa x}$ where x is defect position and ρ_σ DOS in the electrode [13]. Taking into account that the electrodes on either side are the same and the vacancy is in the middle, $\Gamma_{L\sigma} = \Gamma_{R\sigma} \propto \rho_\sigma$.

Then, at resonance ($E = E_d$), $\text{TMR} = (\rho_\uparrow - \rho_\downarrow)^2/4\rho_\uparrow\rho_\downarrow$. Thus, the TMR ratio is proportional to the spin asymmetry (including all states, not just the Δ_1) in the electrodes which is typically not very large. This is applicable to O vacancies lying not too far from the electrodes so that all the transverse states contribute to the conductance. Thus, the resonant mechanism of tunneling leads to moderate values of TMR.

Off resonance tunneling is determined by the lowest decay rate in the insulator. The decay rate, $\kappa = \sqrt{2m^*(U - E)/\hbar^2}$, is determined by the barrier height and the effective mass. The barrier height is not affected by the removal of an O atom but the effective mass is inversely proportional to the hopping integral $t \propto \hbar^2/(2m^*a^2)$ where a is the lattice constant. The absence of an O atom lowers hopping through that site and overall increases the effective mass and the decay rate.

B. Ab Initio

Model considerations suggest that TMR is reduced in the presence of defects in the barrier. We calculate the tunneling conductance in Fe-MgO-Fe(001) MTJs with O vacancies using self-consistent potentials obtained within the tight-binding linear muffin-tin orbital (TB-LMTO) method in the atomic sphere approximation (ASA) [36]. To represent an O vacancy, we replace an O atom by an empty sphere of equal radius. The TB-LMTO electronic structure is compared to VASP calculations for all systems showing excellent agreement. Then, the two-terminal conductance is obtained using the principal-layer Green function technique [33], [37].

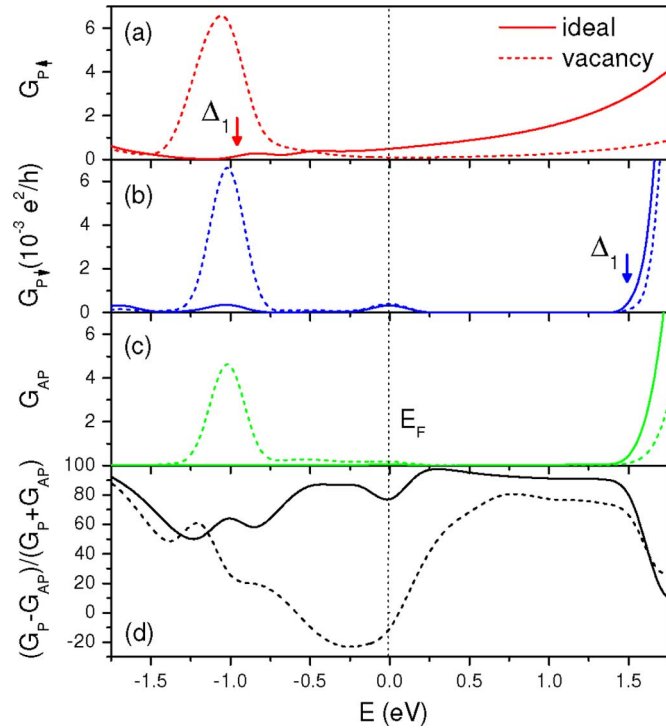


Fig. 5. Conductance per cell and TMR in Fe–MgO–Fe(001) with five layers of MgO for ideal MgO and MgO with O vacancies ($1/8$ cell). (a) Majority-spin and (b) minority-spin in parallel, and (c) either spin in antiparallel configuration conductance. (d) TMR (bound). Arrows indicate the bottom of the majority and minority Δ_1 bands.

Fig. 5(a)–(c) shows conductance as a function of energy for an ideal Fe–MgO–Fe MTJ (solid lines) and for an MTJ with O vacancies (dashed lines). For the ideal MTJ, the conductance plots reveal two characteristic energy points: $E \approx -1$ eV for majority-spin electrons and $E \approx 1.5$ eV for minority-spin electrons [indicated by arrows in Fig. 5(a) and (b)]. Above these energies the conductance increases significantly due to the occurrence of the Δ_1 symmetry bands in the electronic structure of Fe. In the energy interval $(-1, 1.5)$ eV, the Δ_1 band is present only in the majority-spin channel resulting in large values of TMR [5], [6].

O vacancies produce a pronounced peak in the conductance centered around $E = -1$ eV [Fig. 5(a)–(c)]. This peak is due to resonant tunneling of majority- and minority-spin electrons via the F -center s -state. Another peak (not shown) occurs at $E = 3.5$ eV due to the p resonant state. The width of the peak depends strongly on the vacancy density and on the coupling to the electrodes determined by MgO thickness [Fig. 1(b) and (c)]. Notably, TMR [Fig. 5(d)] close to the resonance is reduced because resonant transmission is very similar for all channels, as predicted by the model.

Away from the F -center levels, the resonant contribution to the conductance is negligible. Nevertheless, the transmission of the majority-spin electrons is strongly affected by the presence of O vacancies. This is evident from Fig. 5(a) which shows that at and above E_F the conductance of an MTJ with vacancies is reduced by a factor of 5–7 depending on energy, as compared to the conductance of a perfect MTJ. The detrimental effect of O vacancies on the majority-spin conductance is due to scattering of tunneling electrons between states with different transverse

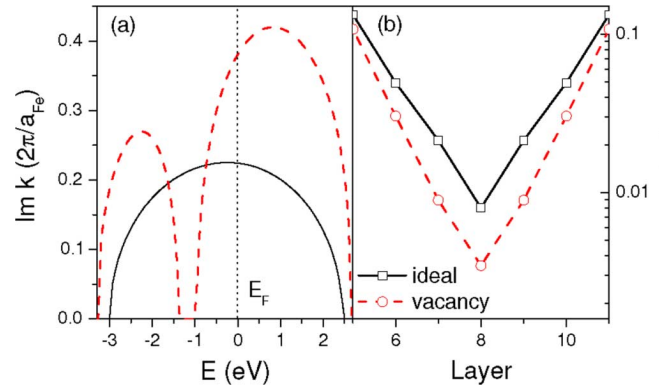


Fig. 6. Decay rate for the Δ_1 -state in ideal MgO (solid lines) and MgO with O vacancies in $(1)/(32)$ cell (dashed lines) obtained from (a) the complex band structure of bulk MgO and (b) from the probability density in Fe–MgO–Fe. The position of the Fermi energy in Fe–MgO–Fe MTJs is at $E = 0$ eV.

wave vectors k_{\parallel} . Scattering to states with $k_{\parallel} \neq 0$ reduces the transmission coefficient due to a shorter decay length of these states.

The reduction of majority-spin conductance in the presence of O vacancies can be understood from the complex band structure [34] by analyzing the evanescent Δ_1 -state which has the lowest decay rate for both ideal and defective MgO crystals. Fig. 6(a) shows the decay rate of the Δ_1 band in an MgO crystal containing O vacancies in a periodic arrangement. The vacancy band, which produces the resonant peaks in the conductance, splits the MgO gap in two parts. Away from resonance, the decay rate of the defective MgO becomes larger than that of the ideal MgO. This implies that electron scattering from F -centers effectively increases the decay constant. A better estimate of the decay rate, accounting for the lack of periodicity in the direction perpendicular to the layers, is to calculate the probability density $|\Psi|^2$ for the Δ_1 -state within the barrier in an Fe–MgO–Fe MTJ [5]. Fig. 6(b) shows $|\Psi|^2$ at E_F . For ideal MgO, the result agrees very well with the complex band structure. The larger slope of the $|\Psi|^2$ graph for defective MgO indicates that the decay rate is about 24% larger than that for the ideal case. This implies seven times smaller transmission probability which is consistent with the actual results [Fig. 5(a)].

The situation is different for minority-spin electrons because in a perfect Fe–MgO–Fe MTJ the conductance is not dominated by $k_{\parallel} = 0$ [33]. In this case, nonresonance scattering by O vacancies may contribute both destructively and constructively to the conductance. We find that the minority-spin conductance in the parallel configuration of MTJ and the either spin conductance in the antiparallel configuration are small, and O vacancies do not have a pronounced effect [Fig. 5(b) and (c)].

The overall effect of O vacancies is the significant reduction of TMR shown in Fig. 5(d) (the bound definition of TMR is used in the graph³). For ideal junctions, TMR is largely controlled by the enhanced transmission of the Δ_1 majority-spin band in the whole energy range $(-1, 1.5)$ eV. The conductance through a defective MgO barrier displays clearly two distinct transport regimes—resonant when the electron energy is close to the position of the vacancy levels and nonresonant when the electron

³An alternative definition is $\text{TMR}' = (G_P - G_{AP})/(G_P + G_{AP})$ which has the advantage of being bound by $\pm 100\%$. The relationship between the two definitions is $\text{TMR}' = \text{TMR}/(2 + \text{TMR})$.

energy is far from the vacancy levels. At resonance, the conductance asymmetry arises only from the difference in the majority and minority DOS in the electrodes. Nonresonance scattering from vacancies diminishes the spin asymmetry by reducing the majority conductance.

Quantitative comparison of TMR below E_F is hindered by the appearance in the minority channel of interface resonant states [33] which interfere with the tail of the resonant transmission complicating the minority and antiparallel conduction. However, above E_F , the tendency is very clear and indicative of what is expected in practice. In agreement with previous calculations [5], [6], [33], we find TMR of ideal MTJs $> 1800\%$. TMR in the presence of O vacancies is reduced to $\lesssim 800\%$. It is worth mentioning that any defects in the barrier, like Mg vacancies, impurities, dislocations, etc., will act in a similar manner, scattering electrons out of coherence, thus reducing the resultant TMR.

V. CONCLUSION

We have found that O vacancies in the MgO film affect significantly the properties of Fe–MgO–Fe MTJs. Measurements of IEC in fully epitaxial Fe–MgO–Fe(001) tunnel junctions show IEC is AFM for small MgO thickness but changes sign and then vanishes for large barrier thickness. Using model and first-principles calculations, we showed that resonant tunneling through F -centers makes IEC AFM for thin barriers but with increasing MgO thickness the resonance contribution to IEC is reduced resulting in the FM coupling typical for perfect MgO barriers. In addition, first-principles calculations show that O vacancies can substantially reduce TMR. We demonstrate that F -centers affect the conductance by either resonant transmission or nonresonant scattering of tunneling electrons, both causing a substantial reduction of TMR compared to the ideal case. Improving the quality of the MgO barrier to reduce O vacancy concentration would improve the properties of Fe–MgO–Fe MTJs.

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